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Substitute for form 1449A/B/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)				Complete If Known	
				Application Number	10/798,347
				Filing Date	March 12, 2004
				First Named Inventor	Giuseppe Rossi
				Art Unit	N/A 2858
				Examiner Name	Not Yet Assigned A. Deb
				Attorney Docket Number	M4065.0642/P642-A
Sheet	1	of	1		

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
/ADI/ ↓ V	AA**	US-5,008,739	04-16-1991	D'Luna et al.	
	AB**	US-5,452,001	09-19-1995	Hosier et al.	
	AC**	US-2003/0202111-A1	10-30-2003	Park	
	AD**	US-6,303,923-B1	10-16-2001	Wadsworth et al.	
	AE**	US-6,607,301-B1	08-19-2003	Glukhovsky et al.	
	AF**	US-5,047,863	09-10-1991	Pape et al.	
	AG**	US-6,144,408	11-07-2000	MacLean	
	AH**	US-4,739,495	04-19-1988	Levine	

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Foreign Patent Document Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear

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/Anjan Deb/ (04/16/2007)

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		Number-Kind Code ² (if known)			
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	B**	5,886,353	03-23-1999	Spivey et al.	
	C**	5,929,689	07-27-1999	Wall	
	D**	5,953,060	09-14-1999	Dierickx	
	E**	6,101,287	08-08-2000	Corum et al.	
	F**	6,330,345	12-11-2001	Russo et al.	
	G**	6,418,241	07-09-2002	Schreiner	

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		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)				

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/ADI/ ↓ ↓ ↓ ↓ ↓	H**	AN03: Guide to Image Quality and Pixel Correction Methods, Rad-icon Imaging Corp,			
	I**	ANTON BAKKER and JOHAN H. HUIJSING; Micropower CMOS Temperature Sensor with Digital Output, IEEE Journal of Solid-State Circuits, Vol. 31, No. 7, July 1996, pp. 933-937.			
	J**	KARIM ARABI and BOZENA KAMINSKA, Built-In Temperature Sensors for On-line Thermal Monitoring of Microelectronic Structures, Proceedings of the 1997 International Conference on Computer Design (ICCD '97), pp. 462-467.			
	K**	LOUIS LUH, JOHN CHOMA, JR., JEFFREY DRAPER, HERMING CHIUH, A High-Speed CMOS On-Chip Temperature Sensor, Proceedings of the European Solid State Circuits Conference, September 1999, pp. 290-293.			
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	M**	M. LOOSE, K. MEIER, J. SCHEMMEL, Self-calibrating logarithmic CMOS image sensor with single chip camera functionality, Contribution to IEEE CCD & AIS workshop, Karuizawa, Japan (1999) R27.			
	N**	HON-SUM WONG, Technology and Device Scaling Considerations for CMOS Imagers, IEEE Transactions on Electron Devices, Vol. 43, No. 12, December 1996, pp. 2131-2142.			
	O**	ERIC R. FOSSUM, Digital Camera System on a Chip, IEEE Micro, May-June 1998, pp. 8-15.			
	P**	C. C. LUI and C. H. MASTRANGELO, CMOS Uncooled Heat-Balancing Infrared Imager, IEEE Journal of Solid-State Circuits, April 2000, pp. 1-9.			

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